Index of Claims 10718376 Examiner Huynh, Son P Applicant(s)/Patent Under Reexamination FICKLE ET AL. Art Unit 2424

✓	Rejected	-	Cancelled	N	Non-Elected	Α	Appeal
=	Allowed	÷	Restricted	I	Interference	0	Objected

CL	AIM	DATE									
-inal	Original	12/14/2007	09/28/2008	05/01/2009	10/01/2009	06/15/2010					
	1	÷	√	√	√	√					+
	2	÷	√	√	√	√					+
	3	÷	√	√	√	√				†	+
	4	÷	✓	√	√	√				†	+
	5	÷	✓	√	✓	√					+
	6	÷	✓	√	✓	√					+
	7	÷	✓	√	✓	✓					+
	8	÷	✓	√	✓	✓					
	9	÷	✓	√	✓	√					
	10	÷	✓	✓	√	√					
	11	÷	✓	✓	✓	✓					
	12	÷	✓	✓	✓	✓					
	13	÷	✓	√	✓	✓					
	14	÷	✓	√	✓	√					
	15	÷	✓	√	✓	✓					
	16	÷	✓	√	✓	✓					
	17	÷	✓	√	✓	✓					
	18	÷	✓	✓	✓	✓					
	19	÷	✓	✓	✓	✓					
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	22	÷	✓	✓	✓	✓					
	23	÷	✓	✓	✓	✓					
	24	÷	✓	✓	✓	✓					
	25	÷	✓	✓	✓	✓					
	26	÷	✓	✓	✓	✓					
	27	÷	✓	✓	✓	✓					
	28	÷	✓	✓	✓	✓					
	29	÷	✓	✓	✓	✓					
	30	÷	✓	✓	✓	✓					
	31	÷	✓	✓	✓	✓					
	32	÷	✓	✓	✓	✓					
	33	÷	✓	✓	✓	✓					
	34	÷	✓	✓	✓	✓					
	35	÷	✓	✓	✓	✓					

	Application/Control No.	Applicant(s)/Patent Under Reexamination			
Index of Claims	10718376	FICKLE ET AL.			
	Examiner	Art Unit			
	Huynh, Son P	2424			

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✓	Rejected		Cancelled	N	N Non-Elected		N Non-Elected		Α	Appeal
=	Allowed	÷	÷ Restricted I Interference			0	Objected			
	Claims renumbered i	n the same o	rder as presented by a	applicant		□ СРА] T.C). 🔲 R.1.47	
	CLAIM	DATE								
Fi	nal Original	renumbered in the same order as presented by applicant CPA T.D. R.1.47 AIM DATE								

☐ Claims renumbered in the same order as presented by applicant ☐ CPA ☐ T.D. ☐ R.1.47										
CL	AIM	DATE								
Final	Original	12/14/2007	09/28/2008	05/01/2009	10/01/2009	06/15/2010				
	37	÷	✓	✓	✓	✓				
	38	÷	✓	✓	✓	✓				
	39	÷	✓	✓	✓	✓				
	40	÷	✓	✓	✓	√				
	41	÷	✓	✓	✓	✓				
	42	÷	✓	✓	✓	✓				
	43	÷	✓	√	✓	✓				
	44	÷	✓	√	✓	✓				
	45	÷	✓	✓	✓	✓				
	46	÷	✓	✓	✓	√				
	47	÷	✓	✓	✓	√				
	48	÷	✓	✓	✓	√				
	49	÷	✓	✓	✓	✓				
	50	÷	✓	✓	✓	✓				
	51	÷	✓	✓	✓	✓				
	52	÷	✓	✓	✓	✓				
	53	÷	✓	√	✓	✓				
	54	÷	✓	√	✓	√				
	55	÷	✓	✓	✓	√				

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